

SN54LV373A, SN74LV373A OCTAL TRANSPARENT D-TYPE LATCHES WITH 3-STATE OUTPUTS

SCLS407B – APRIL 1998 – REVISED MAY 2000

- **EPIC™ (Enhanced-Performance Implanted CMOS) Process**
- **Typical V_{OLP} (Output Ground Bounce) $<0.8\text{ V}$ at $V_{CC} = 3.3\text{ V}$, $T_A = 25^\circ\text{C}$**
- **Typical V_{OHV} (Output V_{OH} Undershoot) $>2.3\text{ V}$ at $V_{CC} = 3.3\text{ V}$, $T_A = 25^\circ\text{C}$**
- **2-V to 5.5-V V_{CC} Operation**
- **Support Mixed-Mode Voltage Operation on All Ports**
- **Latch-Up Performance Exceeds 250 mA Per JESD 17**
- **ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)**
- **Package Options Include Plastic Small-Outline (DW, NS), Shrink Small-Outline (DB), Thin Very Small-Outline (DGV), and Thin Shrink Small-Outline (PW) Packages, Ceramic Flat (W) Packages, Chip Carriers (FK), and DIPs (J)**

description

The 'LV373A devices are octal transparent D-type latches designed for 2-V to 5.5-V V_{CC} operation.

While the latch-enable (LE) input is high, the Q outputs follow the data (D) inputs. When LE is taken low, the Q outputs are latched at the logic levels set up at the D inputs.

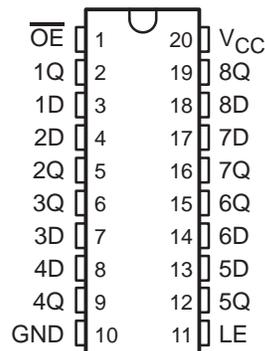
A buffered output-enable (\overline{OE}) input can be used to place the eight outputs in either a normal logic state (high or low) or the high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and increased drive provide the capability to drive bus lines without need for interface or pullup components.

\overline{OE} does not affect the internal operations of the latches. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

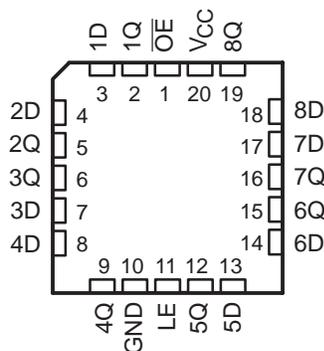
To ensure the high-impedance state during power up or power down, \overline{OE} should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

The SN54LV373A is characterized for operation over the full military temperature range of -55°C to 125°C . The SN74LV373A is characterized for operation from -40°C to 85°C .

SN54LV373A . . . J OR W PACKAGE
SN74LV373A . . . DB, DGV, DW, NS, OR PW PACKAGE
(TOP VIEW)



SN54LV373A . . . FK PACKAGE
(TOP VIEW)



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**TEXAS
INSTRUMENTS**

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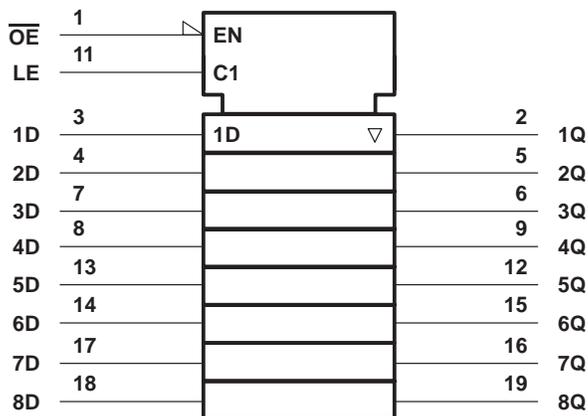
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FUNCTION TABLE
(each latch)

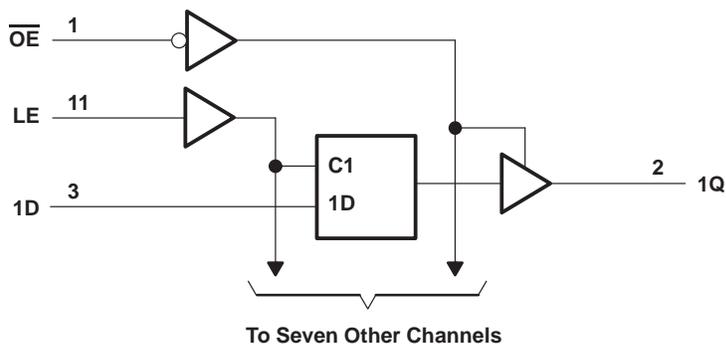
INPUTS			OUTPUT
OE	LE	D	Q
L	H	H	H
L	H	L	L
L	L	X	Q ₀
H	X	X	Z

logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)



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recommended operating conditions (see Note 4)

		SN54LV373A		SN74LV373A		UNIT	
		MIN	MAX	MIN	MAX		
V _{CC}	Supply voltage	2	5.5	2	5.5	V	
V _{IH}	High-level input voltage	V _{CC} = 2 V	1.5	1.5		V	
		V _{CC} = 2.3 V to 2.7 V	V _{CC} × 0.7	V _{CC} × 0.7			
		V _{CC} = 3 V to 3.6 V	V _{CC} × 0.7	V _{CC} × 0.7			
		V _{CC} = 4.5 V to 5.5 V	V _{CC} × 0.7	V _{CC} × 0.7			
V _{IL}	Low-level input voltage	V _{CC} = 2 V	0.5	0.5		V	
		V _{CC} = 2.3 V to 2.7 V	V _{CC} × 0.3	V _{CC} × 0.3			
		V _{CC} = 3 V to 3.6 V	V _{CC} × 0.3	V _{CC} × 0.3			
		V _{CC} = 4.5 V to 5.5 V	V _{CC} × 0.3	V _{CC} × 0.3			
V _I	Input voltage	0	5.5	0	5.5	V	
V _O	Output voltage	High or low state	0	V _{CC}	0	V _{CC}	V
		3-state	0	5.5	0	5.5	
I _{OH}	High-level output current	V _{CC} = 2 V		-50		-50	μA
		V _{CC} = 2.3 V to 2.7 V		-2		-2	
		V _{CC} = 3 V to 3.6 V		-8		-8	mA
		V _{CC} = 4.5 V to 5.5 V		-16		-16	
I _{OL}	Low-level output current	V _{CC} = 2 V		50		50	μA
		V _{CC} = 2.3 V to 2.7 V		2		2	
		V _{CC} = 3 V to 3.6 V		8		8	mA
		V _{CC} = 4.5 V to 5.5 V		16		16	
Δt/Δv	Input transition rise or fall rate	V _{CC} = 2.3 V to 2.7 V	0	200	0	200	ns/V
		V _{CC} = 3 V to 3.6 V	0	100	0	100	
		V _{CC} = 4.5 V to 5.5 V	0	20	0	20	
T _A	Operating free-air temperature	-55	125	-40	85	°C	

NOTE 4: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V _{CC}	SN54LV373A			SN74LV373A			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
V _{OH}	I _{OH} = -50 μA	2 V to 5.5 V	V _{CC} -0.1			V _{CC} -0.1			V
	I _{OH} = -2 mA	2.3 V	2			2			
	I _{OH} = -8 mA	3 V	2.48			2.48			
	I _{OH} = -16 mA	4.5 V	3.8			3.8			
V _{OL}	I _{OL} = 50 μA	2 V to 5.5 V				0.1			V
	I _{OL} = 2 mA	2.3 V				0.4			
	I _{OL} = 8 mA	3 V				0.44			
	I _{OL} = 16 mA	4.5 V				0.55			
I _I	V _I = V _{CC} or GND	0 V to 5.5 V				±1			μA
I _{OZ}	V _O = V _{CC} or GND	5.5 V				±5			μA
I _{CC}	V _I = V _{CC} or GND, I _O = 0	5.5 V				20			μA
I _{off}	V _I or V _O = 0 to 5.5 V	0 V				5			μA
C _i	V _I = V _{CC} or GND	3.3 V	2.9			2.9			pF

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timing requirements over recommended operating free-air temperature range, $V_{CC} = 2.5\text{ V} \pm 0.2\text{ V}$ (unless otherwise noted) (see Figure 1)

		$T_A = 25^\circ\text{C}$		SN54LV373A		SN74LV373A		UNIT
		MIN	MAX	MIN	MAX	MIN	MAX	
t_w	Pulse duration, LE high	6		6.5		6.5		ns
t_{su}	Setup time, data before LE↓	4.5		5		5		ns
t_h	Hold time, data after LE↓	1.5		1.5		1.5		ns

timing requirements over recommended operating free-air temperature range, $V_{CC} = 3.3\text{ V} \pm 0.3\text{ V}$ (unless otherwise noted) (see Figure 1)

		$T_A = 25^\circ\text{C}$		SN54LV373A		SN74LV373A		UNIT
		MIN	MAX	MIN	MAX	MIN	MAX	
t_w	Pulse duration, LE high	5		5		5		ns
t_{su}	Setup time, data before LE↓	4		4		4		ns
t_h	Hold time, data after LE↓	1		1		1		ns

timing requirements over recommended operating free-air temperature range, $V_{CC} = 5\text{ V} \pm 0.5\text{ V}$ (unless otherwise noted) (see Figure 1)

		$T_A = 25^\circ\text{C}$		SN54LV373A		SN74LV373A		UNIT
		MIN	MAX	MIN	MAX	MIN	MAX	
t_w	Pulse duration, LE high	5		5		5		ns
t_{su}	Setup time, data before LE↓	4		4		4		ns
t_h	Hold time, data after LE↓	1		1		1		ns

switching characteristics over recommended operating free-air temperature range, $V_{CC} = 2.5\text{ V} \pm 0.2\text{ V}$ (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE	$T_A = 25^\circ\text{C}$			SN54LV373A		SN74LV373A		UNIT
				MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t_{pd}	D	Q	$C_L = 15\text{ pF}$	8.3*	15.2*		1*	17*	1	17	ns
	LE	Q		9.1*	15.7*		1*	19*	1	19	
t_{en}	\overline{OE}	Q		8.9*	15.8*		1*	19*	1	19	
t_{dis}	\overline{OE}	Q		6.2*	12.6*		1*	15*	1	15	
t_{pd}	D	Q	$C_L = 50\text{ pF}$	10.4	18		1	21	1	21	ns
	LE	Q		11.1	18.6		1	22	1	22	
t_{en}	\overline{OE}	Q		10.9	18.8		1	22	1	22	
t_{dis}	\overline{OE}	Q		8.3	17.4		1	19	1	19	
$t_{sk(o)}$						2				2	

* On products compliant to MIL-PRF-38535, this parameter is not production tested.

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switching characteristics over recommended operating free-air temperature range,
 $V_{CC} = 3.3\text{ V} \pm 0.3\text{ V}$ (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE	$T_A = 25^\circ\text{C}$			SN54LV373A		SN74LV373A		UNIT
				MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t_{pd}	D	Q	$C_L = 15\text{ pF}$	5.8*	11.4*	1*	13.5*	1	13.5	ns	
	LE	Q		6.4*	11*	1*	13*	1	13		
t_{en}	\overline{OE}	Q		6.3*	11.4*	1*	13.5*	1	13.5		
t_{dis}	\overline{OE}	Q		4.7*	10*	1*	12*	1	12		
t_{pd}	D	Q		$C_L = 50\text{ pF}$	7.3	14.9	1	17	1	17	ns
	LE	Q			7.8	14.5	1	16.5	1	16.5	
t_{en}	\overline{OE}	Q			7.7	14.9	1	17	1	17	
t_{dis}	\overline{OE}	Q			6	13.2	1	15	1	15	
$t_{sk(o)}$					1.5				1.5		

* On products compliant to MIL-PRF-38535, this parameter is not production tested.

switching characteristics over recommended operating free-air temperature range,
 $V_{CC} = 5\text{ V} \pm 0.5\text{ V}$ (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE	$T_A = 25^\circ\text{C}$			SN54LV373A		SN74LV373A		UNIT
				MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t_{pd}	D	Q	$C_L = 15\text{ pF}$	4.1*	7.2*	1*	8.5*	1	8.5	ns	
	LE	Q		4.5*	7.2*	1*	8.5*	1	8.5		
t_{en}	\overline{OE}	Q		4.5*	8.1*	1*	9.5*	1	9.5		
t_{dis}	\overline{OE}	Q		3.3*	7.2*	1*	8.5*	1	8.5		
t_{pd}	D	Q	$C_L = 50\text{ pF}$	5.1	9.2	1	10.5	1	10.5	ns	
	LE	Q		5.5	9.2	1	10.5	1	10.5		
t_{en}	\overline{OE}	Q		5.5	10.1	1	11.5	1	11.5		
t_{dis}	\overline{OE}	Q		4	9.2	1	10.5	1	10.5		
$t_{sk(o)}$					1				1		

* On products compliant to MIL-PRF-38535, this parameter is not production tested.

noise characteristics, $V_{CC} = 3.3\text{ V}$, $C_L = 50\text{ pF}$, $T_A = 25^\circ\text{C}$ (see Note 5)

PARAMETER		SN74LV373A			UNIT
		MIN	TYP	MAX	
$V_{OL(P)}$	Quiet output, maximum dynamic V_{OL}		0.6	0.8	V
$V_{OL(V)}$	Quiet output, minimum dynamic V_{OL}		-0.6	-0.8	V
$V_{OH(V)}$	Quiet output, minimum dynamic V_{OH}		2.9		V
$V_{IH(D)}$	High-level dynamic input voltage		2.31		V
$V_{IL(D)}$	Low-level dynamic input voltage			0.99	V

NOTE 5: Characteristics are for surface-mount packages only.

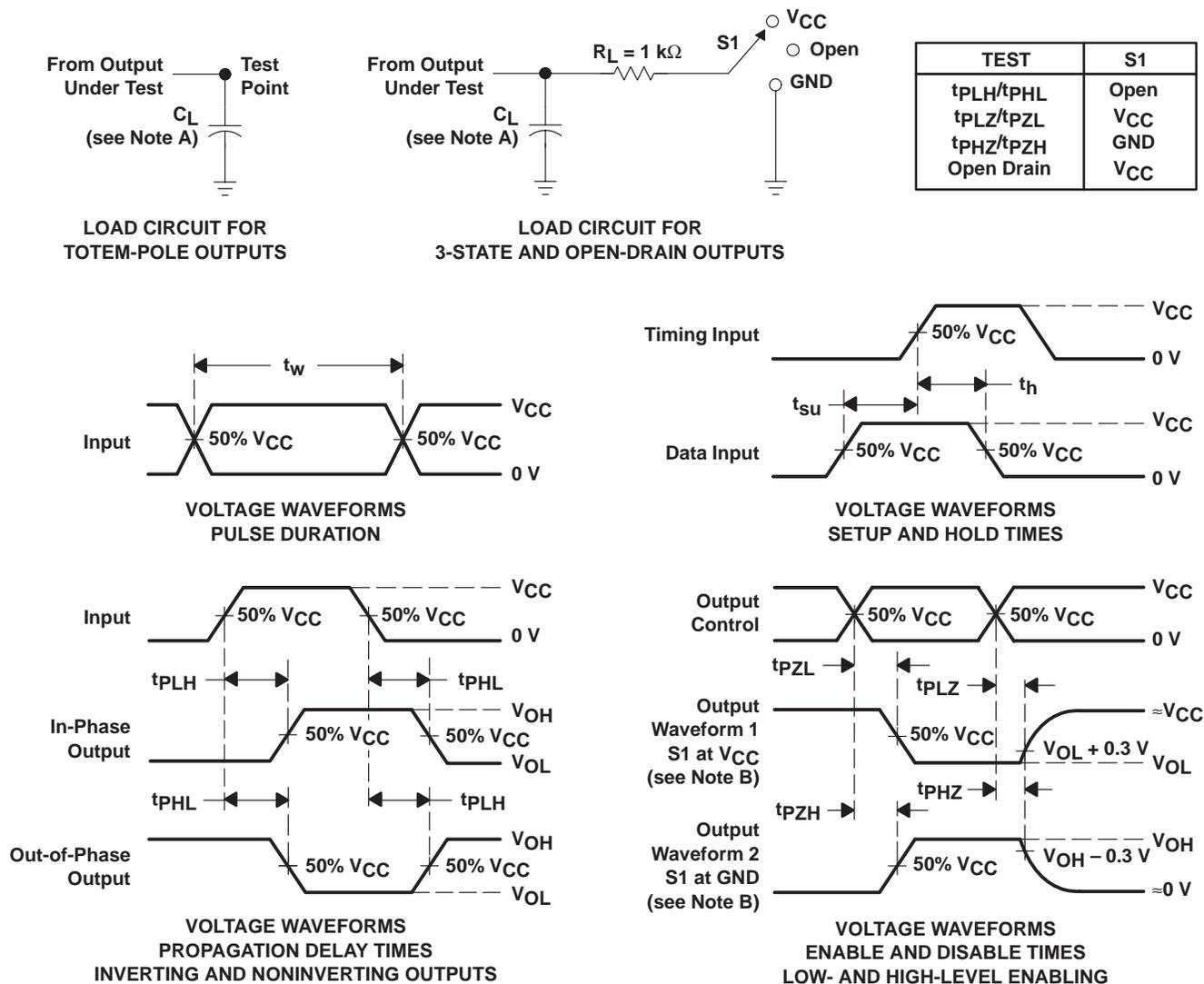
operating characteristics, $T_A = 25^\circ\text{C}$

PARAMETER		TEST CONDITIONS	V_{CC}	TYP	UNIT
C_{pd}	Power dissipation capacitance		Outputs enabled	3.3 V	
			5 V	19.5	

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PARAMETER MEASUREMENT INFORMATION



- NOTES:
- A. C_L includes probe and jig capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 - C. All input pulses are supplied by generators having the following characteristics: $PRR \leq 1\text{ MHz}$, $Z_O = 50\ \Omega$, $t_r \leq 3\text{ ns}$, $t_f \leq 3\text{ ns}$.
 - D. The outputs are measured one at a time with one input transition per measurement.
 - E. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
 - F. t_{PZL} and t_{PZH} are the same as t_{en} .
 - G. t_{PHL} and t_{PLH} are the same as t_{pd} .

Figure 1. Load Circuit and Voltage Waveforms

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